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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
09/491,302	01/25/2000	John D. Geissinger	55271USA6A	8370

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EXAMINER

BROCK II, PAUL E

ART UNIT	PAPER NUMBER
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2815

DATE MAILED: 11/05/2004

Please find below and/or attached an Office communication concerning this application or proceeding.

Office Action Summary

Application No.

09/491,302

Applicant(s)

GEISSINGER ET AL.

Examiner

Paul E Brock II

Art Unit

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-- The MAILING DATE of this communication appears on the cover sheet with the correspondence address --

Period for Reply

A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 3 MONTH(S) FROM THE MAILING DATE OF THIS COMMUNICATION.

- Extensions of time may be available under the provisions of 37 CFR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing date of this communication.
- If the period for reply specified above is less than thirty (30) days, a reply within the statutory minimum of thirty (30) days will be considered timely.
- If NO period for reply is specified above, the maximum statutory period will apply and will expire SIX (6) MONTHS from the mailing date of this communication.
- Failure to reply within the set or extended period for reply will, by statute, cause the application to become ABANDONED (35 U.S.C. § 133). Any reply received by the Office later than three months after the mailing date of this communication, even if timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.704(b).

Status

- 1) ☒ Responsive to communication(s) filed on 16 August 2004.
- 2a) ☐ This action is **FINAL**. 2b) ☒ This action is non-final.
- 3) ☐ Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under *Ex parte Quayle*, 1935 C.D. 11, 453 O.G. 213.

Disposition of Claims

- 4) ☒ Claim(s) 1-4 and 8-19 is/are pending in the application.
- 4a) Of the above claim(s) _____ is/are withdrawn from consideration.
- 5) ☐ Claim(s) _____ is/are allowed.
- 6) ☒ Claim(s) 1-4 and 8-19 is/are rejected.
- 7) ☐ Claim(s) _____ is/are objected to.
- 8) ☐ Claim(s) _____ are subject to restriction and/or election requirement.

Application Papers

- 9) ☐ The specification is objected to by the Examiner.
- 10) ☒ The drawing(s) filed on 25 January 2000 is/are: a) ☒ accepted or b) ☐ objected to by the Examiner.
Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).
Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d).
- 11) ☐ The oath or declaration is objected to by the Examiner. Note the attached Office Action or form PTO-152.

Priority under 35 U.S.C. § 119

- 12) ☐ Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).
- a) ☐ All b) ☐ Some * c) ☐ None of:
1. ☐ Certified copies of the priority documents have been received.
 2. ☐ Certified copies of the priority documents have been received in Application No. _____.
 3. ☐ Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)).

* See the attached detailed Office action for a list of the certified copies not received.

Attachment(s)

- | | |
|--|---|
| 1) <input checked="" type="checkbox"/> Notice of References Cited (PTO-892) | 4) <input type="checkbox"/> Interview Summary (PTO-413)
Paper No(s)/Mail Date. _____ |
| 2) <input type="checkbox"/> Notice of Draftsperson's Patent Drawing Review (PTO-948) | 5) <input type="checkbox"/> Notice of Informal Patent Application (PTO-152) |
| 3) <input type="checkbox"/> Information Disclosure Statement(s) (PTO-1449 or PTO/SB/08)
Paper No(s)/Mail Date _____ | 6) <input type="checkbox"/> Other: _____ |

DETAILED ACTION

Claim Objections

1. It is noted that in the amendment filed January 23, 2004 and the Appeal Brief filed August 16, 2004 that applicant has labeled claims 5 – 7 and 20 – 26 as “withdrawn”. Applicant cancelled claims 5 – 7 and 20 – 26 in the amendment filed July 7, 2003, and therefore, these claims are cancelled for all further prosecution.

Claim Rejections - 35 USC § 103

2. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negated by the manner in which the invention was made.

3. Claims 1 – 4 and 8 – 19 are rejected under 35 U.S.C. 103(a) as being unpatentable over Schueller et al. (USPAT 5844168, Schueller) in view of Brandt et al. (USPAT 6068782, Brandt).

With regard to claim 1, Schueller discloses in figures 7 – 7b an electronic package. Schueller discloses in figures 7 – 7b a conductive trace layer (720b) having a first side and a second side, the conductive trace layer being patterned to define a plurality of interconnect pads. Schueller discloses in figures 7 – 7b a dielectric substrate (720a) mounted on the first side of the conductive trace layer. Schueller discloses in figures 7 – 7b and column 8, lines 42 – 44 an embedded capacitor (bottom layer of 710, top layer of 700, and the bottom layer of 700) having a capacitance including a first conductive layer (bottom layer of 710), a second conductive layer (bottom layer of 700) and a layer of dielectric material (top layer of 700) made of a non-

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conductive polymer (polyimide, top layer of 700) disposed between the first and the second conductive layers, the first conductive layer attached to the second side of the conductive trace layer by a first adhesive layer (725). It is inherent in the method of Schueller that the bottom layer of 710, top layer of 700, and the bottom layer of 700 form a capacitor because this configuration is the definition of a capacitor. Schueller is silent to teaching a specific capacitance and a dielectric material made of a non-conductive polymer blended with high dielectric constant particles. Brandt teaches in column 4, lines 18 – 41 and column a suitable dielectric material made of a non-conductive polymer blended with high dielectric particles. Brandt further teaches in column 6, lines 44 – 60 a capacitor with this dielectric layer having a capacitance of 200 nF/sq.cm (500 pF is equivalent to 50 nF, $(50 \text{ nF})/(0.25 \text{ cm}^2) = 200 \text{ nF/cm}^2$). It would have been obvious to one of ordinary skill in the art at the time of the present invention to use the dielectric material and capacitance of Brandt in the method of Kling in order to tune the electronic properties of a capacitor component as stated by Brandt in column 4, lines 22 – 41. It further would have been obvious to one of ordinary skill in the art at the time of the present invention to use a capacitance of from about 1nF/sq.cm to about 100 nF/sq.cm in order to optimize the capacitance, and because Brandt teaches optimization in column 4, lines 37 – 41 (also see MPEP 2144.05). Schueller discloses in figures 7 – 7b a plurality of interconnect regions (741 and 742) extending through the first conductive layer and the dielectric material layer of the capacitor. Schueller discloses in figures 7 – 7b an interconnect member connected between each of the conductive layers of the capacitor and a corresponding set of the interconnect pads, the first conductive layer of the capacitor being electrically connected (750) to a first set of the interconnect pads and the second conductive layer on the capacitor being

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electrically connected (751) to a second set of the interconnect pads, the interconnect members corresponding to the second set of interconnect pads extending through one of the interconnect regions.

With regard to claim 2, Brandt teaches in column 2, lines 30 – 33 wherein an embedded capacitor has the first electrode maintained at a first reference voltage and wherein the second electrode is maintained at a second reference voltage different from the first reference voltage. It is well known in the art that power and ground planes are maintained at reference voltages. Further, this is an intended use recitation that bears no patentable weight in a device claim.

With regard to claim 3, Schueller discloses in figures 7 – 7b and column 6, lines 28 – 30 an electrically conductive stiffening member (310) attached to the second conductive layer of the capacitor by a second adhesive layer (325).

With regard to claim 4, Schueller discloses in figures 7 – 7b a device receiving region (directly under 315) extending through the dielectric substrate, the conductive trace layer and the capacitor, and further comprising an electronic device (315) attached to the device receiving region on the stiffening member by a third adhesive layer (portion of 310b between 315 and 310, as labeled in figure 3).

With regard to claims 8 – 9, as discussed in the rejection of claim 1 above, Schueller and Brandt obviously teach the capacitor has a capacitance of 15 nF/sq.cm. MPEP 2144.05 states that the optimization of ranges within the prior art conditions, or through routine experimentation is obvious. It would have been obvious to one of ordinary skill in the art to use a capacitor that has a capacitance of about 2 nF/sq.cm. to about 30 nF/sq.cm because the optimization of ranges would have been obvious through routine experimentation in Schueller and Brandt.

With regard to claim 10, as discussed in the rejection of claim 1 above, Schueller and Brandt obviously teach the capacitor has a capacitance of at least 30 nF/sq.cm. MPEP 2144.05 states that overlapping ranges are obvious.

With regard to claim 11, Schueller discloses in column 7, lines 3 – 6 and Brandt teaches in column 4, lines 35 – 37 wherein the dielectric material of the capacitor has a thickness of 0.5 microns to about 30 microns. (see MPEP 2144.05, and note that 1mil = 25.4 microns).

With regard to claim 12, Brandt discloses in column 4, lines 18 – 41 wherein the dielectric material of the capacitor includes a metal oxide.

With regard to claim 13, Brandt discloses in column 4, lines 18 – 41 the high dielectric constant particles are formed from a material of lead zirconium titanate.

With regard to claim 14, Schueller discloses in figures 7 – 7b wherein the dielectric substrate includes a plurality of apertures, each one of the apertures being positioned adjacent to one of the interconnect region of the capacitor.

With regard to claims 15 – 16, Schueller discloses in figures 7 – 7b and column 7, lines 7 – 13 wherein the dielectric substrate includes a polyimide.

With regard to claim 17, Schueller discloses in figures 7 – 7b and column 2, lines 65 – 67 wherein the interconnect member is a solder plug (750 – 752).

With regard to claim 18, Schueller discloses in figures 7 – 7b wherein each interconnect pad is a solderball pad (340).

With regard to claim 19, Schueller discloses in figures 7 – 7b wherein the dielectric substrate has an aperture (portion filled by 365 in figure 7b) extending therethrough adjacent to each solderball pad.

Response to Arguments

4. Applicant's arguments with respect to claims 1 – 4 and 8 – 19 have been considered but are moot in view of the new ground(s) of rejection.

Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Paul E Brock II whose telephone number is (571) 272-1723. The examiner can normally be reached on 8:30 AM - 5:30 PM.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Tom Thomas can be reached on (571) 272-1664. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see <http://pair-direct.uspto.gov>. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

Paul E Brock II


Tom Thomas

TOM THOMAS
SUPERVISORY PATENT EX
TECHNOLOGY CENTE